

**Product data sheet** 

## 1. General description

Dual ultrafast power diodes in a TO220 plastic package. These diodes are rugged with a guaranteed electrostatic discharge voltage capability.

### 2. Features and benefits

- Fast switching
- Low on-state losses
- Guaranteed ESD capability
- · Low thermal resistance
- High thermal cycling performance
- Soft recovery minimizes power-consuming oscillations

### 3. Applications

• Output rectifiers in high-frequency switched-mode power supplies

### 4. Quick reference data

| Table 1. Q         | uick reference data                    |  |             |   |      |       |      |
|--------------------|--|--|-------------|---|------|-------|------|
| Symbol             | Parameter                              | Conditions   | Values      |   |      |       | Unit |
| Absolute           | maximum rating                         |  |             |   |      |       |      |
| $V_{\text{RRM}}$   | repetitive peak reverse voltage        |  | 200         |   |      |       | V    |
| I <sub>O(AV)</sub> | average output current                 | square-wave pulse; $\delta = 0.5$ ; $T_{mb} \le 119$ °C;<br>both diodes conducting; Fig. 1; Fig. 2   |             |   | 10   |       | A    |
| I <sub>FRM</sub>   | repetitive peak forward<br>current     | δ = 0.5; t <sub>p</sub> = 25 μs; T <sub>mb</sub> ≤ 119 °C; per diode; square-wave pulse  | 10          |   |      | A     |      |
| I <sub>FSM</sub>   | non-repetitive peak<br>forward current | $t_p$ = 10 ms; sine-wave pulse; $T_{j(init)}$ = 25 °C; per diode   | 50          |   |      | A     |      |
|                    |  | $t_p$ = 8.3 ms; sine-wave pulse; $T_{j(init)}$ = 25 °C; per diode  |             |   | A    |       |      |
| Symbol             | Parameter                              | Conditions   | Min Typ Max |   | Unit |       |      |
| Static ch          | aracteristics                          |  |             |   |      |       |      |
| V <sub>F</sub>     | forward voltage                        | I <sub>F</sub> = 5 A; T <sub>j</sub> = 150 °C; <u>Fig. 4</u>   |             | - | 0.8  | 0.895 | V    |
| Dynamic            | characteristics                        | 1  |             |   |      |       |      |
| t <sub>rr</sub>    | reverse recovery time                  | $I_F = 1 \text{ A}; V_R = 30 \text{ V}; \text{ d}_F/\text{d}t = 100 \text{ A}/\mu\text{s};$<br>$T_j = 25 \text{ °C}; \text{ ramp recovery; } Fig. 5$ | - 15 25     |   | ns   |       |      |
| Electros           | atic discharge                         | ·  |             |   | ·    |       |      |
| $V_{\text{ESD}}$   | electrostatic discharge voltage        | HBM; C = 250 pF; R = 1.5 k $\Omega$ ; all pins   |             | - | -    | 8     | kV   |

# 5. Pinning information

| Pin | Symbol | Description            | Simplified outline                                  | Graphic symbol |
|-----|--------|------------------------|---|----------------|
| 1   | A1     | anode 1                | mb  |                |
| 2   | К      | cathode                |   |                |
| 3   | A2     | anode 2                |   |                |
| mb  | К      | mounting base; cathode | O<br>()()()()<br>()()()()<br>()()()()()<br>()()()() | K<br>sym125    |

# 6. Ordering information

| Table 3. Ordering information |                 |                       |                |                           |                 |                       |  |
|-------------------------------|-----------------|-----------------------|----------------|---------------------------|-----------------|-----------------------|--|
| Type number                   | Package<br>Name | Orderable part number | Packing method | Small packing<br>quantity | Package version | Package<br>issue date |  |
| BYQ28E-200E                   | TO220           | BYQ28E-200E,127       | Tube           | 50                        | TO220E (E)      | 26-Apr-2019           |  |
|                               |                 |                       |                |                           | SOT78 (A & d)   | 13-Jun-2008           |  |
| BYQ28E-200                    | TO220           | BYQ28E-200,127        | Tube           | 50                        | SOT78 (A)       | 13-Jun-2008           |  |

## 7. Marking

### Table 4. Marking codes

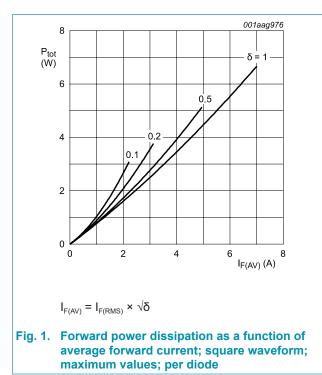
| Tuno number | Marking codes                |                              |                              |  |  |  |
|-------------|------------------------------|------------------------------|------------------------------|--|--|--|
| Type number | Assembley Factory: E         | Assembley Factory: A         | Assembley Factory: d         |  |  |  |
| BYQ28E-200E | BYQ28E<br>200E<br>PJExxxx xx | BYQ28E<br>200E<br>PJAxxxx xx | BYQ28E<br>200E<br>PJdxxxx xx |  |  |  |
| BYQ28E-200  | -                            | BYQ28E<br>200<br>PJAxxxx xx  | -                            |  |  |  |

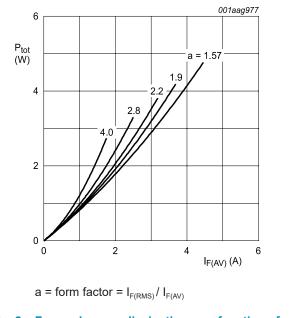
## 8. Limiting values

### Table 5. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

| Symbol             | Parameter                              | Conditions   | Values     | Unit |
|--------------------|--|--|------------|------|
| V <sub>RRM</sub>   | repetitive peak reverse voltage        |  | 200        | V    |
| $V_{\text{RWM}}$   | crest working reverse voltage          |  | 200        | V    |
| V <sub>R</sub>     | reverse voltage                        | DC   | 200        | V    |
| I <sub>O(AV)</sub> | average output current                 | δ = 0.5; square-wave pulse; T <sub>mb</sub> ≤ 119 °C;<br>both diodes conducting; <u>Fig. 1</u> ; <u>Fig. 2</u> | 10         | A    |
| I <sub>FRM</sub>   | repetitive peak forward current        | δ = 0.5; t <sub>p</sub> = 25 μs; T <sub>mb</sub> ≤ 119 °C;<br>per diode; square-wave pulse                     | 10         | A    |
| I <sub>FSM</sub>   | non-repetitive peak<br>forward current | $t_p$ = 10 ms; sine-wave pulse; $T_{j(init)}$ = 25 °C; per diode   | 50         | A    |
|                    |  | $t_p$ = 8.3 ms; sine-wave pulse; $T_{j(init)}$ = 25 °C; per diode  | 55         | A    |
| I <sub>RRM</sub>   | repetitive peak reverse current        | $\delta$ = 0.001; t <sub>p</sub> = 2 µs  | 0.2        | A    |
| I <sub>RSM</sub>   | non-repetitive peak<br>reverse current | t <sub>p</sub> = 100 μs  | 0.2        | A    |
| T <sub>stg</sub>   | storage temperature                    |  | -40 to 150 | °C   |
| Tj                 | junction temperature                   |  | 150        | °C   |
| Electrosta         | tic discharge                          |  | ·          |      |
| $V_{\text{ESD}}$   | electrostatic discharge voltage        | HBM; C = 250 pF; R = 1.5 k $\Omega$ ; all pins   | 8          | kV   |

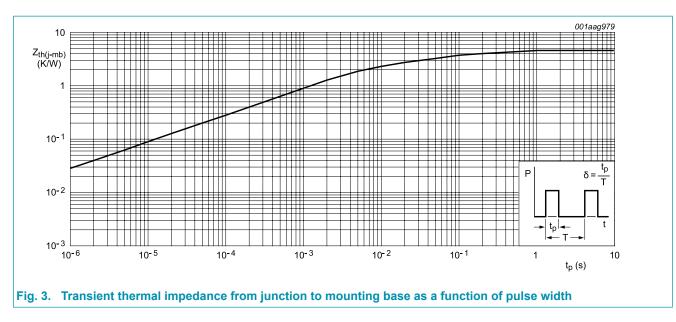






## 9. Thermal characteristics

| Symbol                | Parameter   | Conditions  | Min | Тур | Max | Unit |
|-----------------------|---|---|-----|-----|-----|------|
| $R_{\text{th(j-mb)}}$ | thermal resistance from junction to               | with heatsink compound;<br>both diodes conducting   | -   | -   | 3   | K/W  |
|                       | mounting base                                     | with heatsink compound;<br>per diode; <u>Fig. 3</u> | -   | -   | 4.5 | K/W  |
| $R_{\text{th(j-a)}}$  | thermal resistance<br>from junction to<br>ambient |   | -   | 60  | -   | K/W  |



## **10. Characteristics**

| Symbol          | Parameter                     | Conditions  | Min | Тур  | Max   | Unit |
|-----------------|-------------------------------|---|-----|------|-------|------|
| Static cha      | aracteristics                 |   |     |      |       |      |
| V <sub>F</sub>  | forward voltage               | I <sub>F</sub> = 5 A; T <sub>j</sub> = 150 °C; <u>Fig. 4</u>  | -   | 0.8  | 0.895 | V    |
|                 |                               | I <sub>F</sub> = 5 A; T <sub>j</sub> = 25 °C; <u>Fig. 4</u>   | -   | 0.95 | 1.1   | V    |
|                 |                               | I <sub>F</sub> = 10 A; T <sub>j</sub> = 25 °C; <u>Fig. 4</u>  | -   | 1.1  | 1.25  | V    |
| I <sub>R</sub>  | reverse current               | V <sub>R</sub> = 200 V; T <sub>j</sub> = 25 °C  | -   | 2    | 10    | μA   |
|                 |                               | V <sub>R</sub> = 200 V; T <sub>j</sub> = 100 °C   | -   | 0.1  | 0.2   | mA   |
| Dynamic         | characteristics               |   |     |      |       |      |
| Q <sub>r</sub>  | recovered charge              | $I_F = 2 \text{ A}; V_R = 30 \text{ V}; \text{ d}I_F/\text{d}t = 20 \text{ A}/\mu\text{s};$<br>$T_j = 25 \text{ °C}; Fig. 5$  | -   | 4    | 9     | nC   |
| t <sub>rr</sub> | reverse recovery time         | $I_F = 1 \text{ A}; V_R = 30 \text{ V}; dI_F/dt = 100 \text{ A}/\mu\text{s};$<br>ramp recovery; $T_j = 25 \text{ °C}; Fig. 5$ | -   | 15   | 25    | ns   |
|                 |                               | $I_F = 0.5 \text{ A}; I_R = 1 \text{ A}; \text{ step recovery};$<br>$T_j = 25 \text{ °C}; \frac{\text{Fig. 6}}{2}$            | -   | 10   | 20    | ns   |
| I <sub>RM</sub> | peak reverse recovery current | $I_F = 2 \text{ A}; V_R = 30 \text{ V}; \text{ d}I_F/\text{d}t = 20 \text{ A}/\mu\text{s};$<br>$T_j = 25 \text{ °C}; Fig. 5$  | -   | 0.4  | 0.7   | A    |
| $V_{FR}$        | forward recovery voltage      | I <sub>F</sub> = 1 A; dI <sub>F</sub> /dt = 10 A/μs; T <sub>j</sub> = 25 °C;<br>Fig. 7  | -   | 1    | -     | V    |

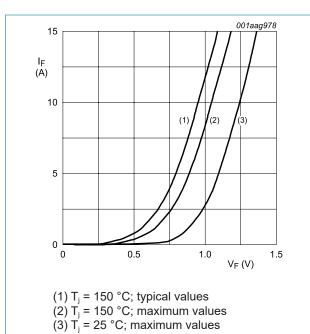
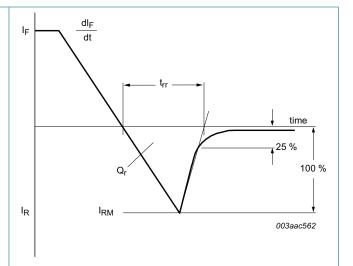
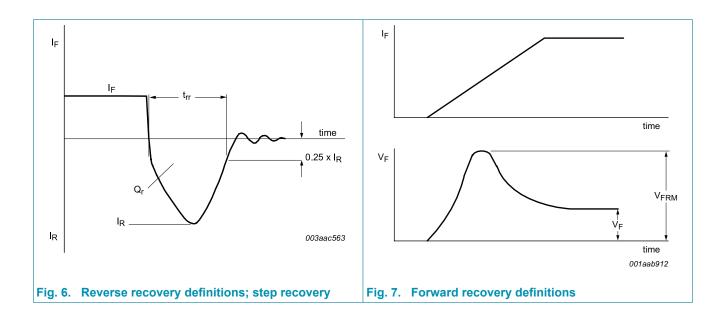


Fig. 4. Forward current as a function of forward voltage



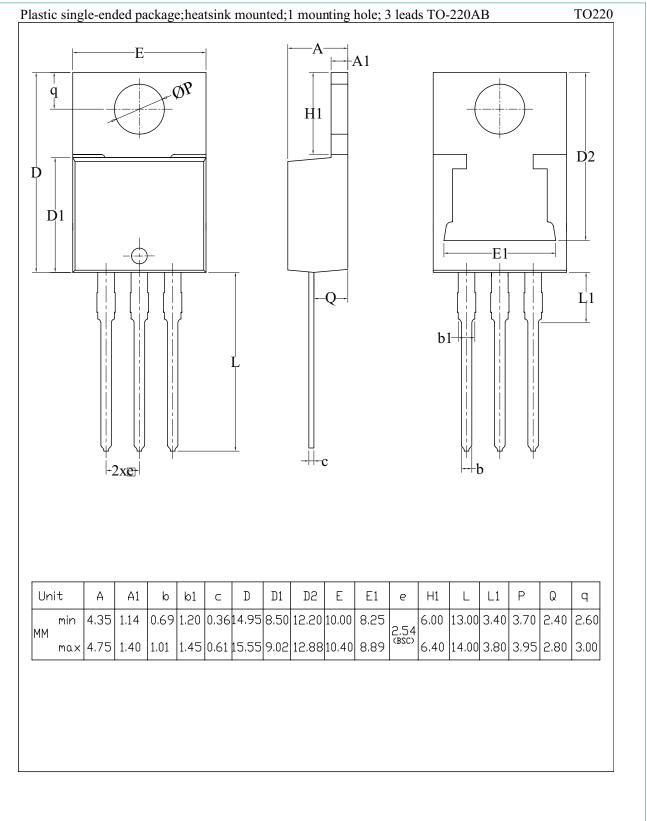


**Dual ultrafast power diodes** 

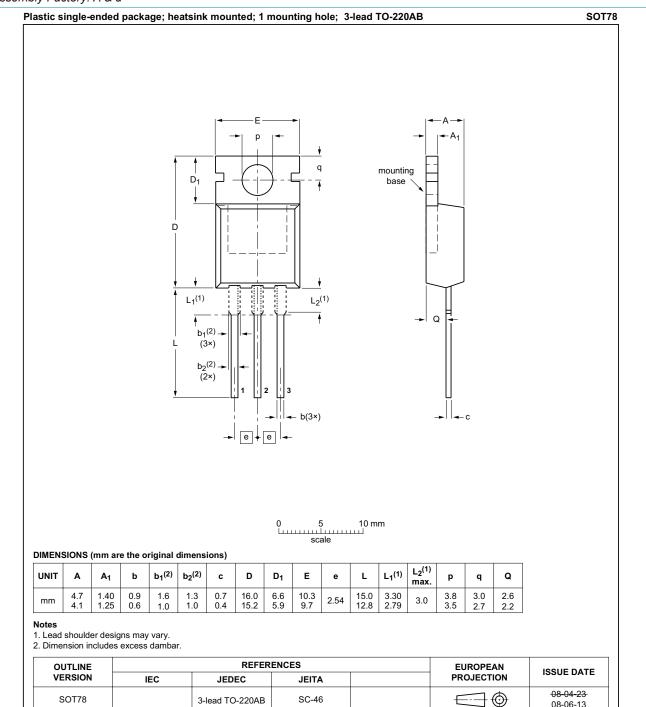


## **11. Package outline**

### Assembly Factory: E



### Assembly Factory: A & d



08-06-13

# **12. Revision history**

| Table 8. Revision histor | ry  |                       |               |                   |  |  |  |
|--------------------------|---|-----------------------|---------------|-------------------|--|--|--|
| Document ID              | Release date  | Data sheet status     | Change notice | Supersedes        |  |  |  |
| BYQ28E-200E v.7          | 20240125  | Product data sheet    | -             | BYQ28E-200E v.6   |  |  |  |
| Modifications:           | Modifications: Merged with BYQ28E-200   |                       |               |                   |  |  |  |
| BYQ28E-200E v.6          | 20201208  | Product data sheet    | -             | BYQ28E-200E v.5   |  |  |  |
| Modifications:           | Update POD  |                       |               |                   |  |  |  |
| BYQ28E-200E v.5          | 20180605  | Product data sheet    | -             | BYQ28E-200E v.4   |  |  |  |
| Modifications:           | Change from NXP version to  | WeEn version          |               |                   |  |  |  |
| BYQ28E-200E v.4          | 20110714  | Product data sheet    | -             | BYQ28E_SERIES v.3 |  |  |  |
| Modifications:           | <ul> <li>Type number BYQ28E-200E separated from data sheet BYQ28E_SERIES v.3.</li> <li>The format of this data sheet has been redesigned to comply with the new identity guidelines of NXP Semiconductors.</li> <li>Legal texts have been adapted to the new company name where appropriate.</li> </ul> |                       |               |                   |  |  |  |
| BYQ28E_SERIES v.3        | 19981001  | Product specification | -             | BYQ28E_SERIES v.2 |  |  |  |

## **BYQ28E-200E**

### **Dual ultrafast power diodes**

## 13. Legal information

#### Data sheet status

| Document status [1][2]               | Product<br>status [3] | Definition  |
|--------------------------------------|-----------------------|---|
| Objective<br>[short] data<br>sheet   | Development           | This document contains data from<br>the objective specification for product<br>development. |
| Preliminary<br>[short] data<br>sheet | Qualification         | This document contains data from the preliminary specification.                             |
| Product<br>[short] data<br>sheet     | Production            | This document contains the product specification.   |

[1] Please consult the most recently issued document before initiating or completing a design.

- [2] The term 'short data sheet' is explained in section "Definitions".
- [3] The product status of device(s) described in this document may have changed since this document was published and may differ in case of multiple devices. The latest product status information is available on the Internet at URL <u>http://www.ween-semi.com</u>.

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